



**PATENT APPLICATION**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

|                                     |   |                                |
|-------------------------------------|---|--------------------------------|
| In re Application of                | ) |                                |
|                                     | ) |                                |
| Francis R. CIRILLO, et al.          | ) | Group Art Unit: TBA            |
|                                     | ) |                                |
| Serial No.: 10/772,009              | ) | Examiner: TBA                  |
|                                     | ) |                                |
| Filed: February 3, 2004             | ) | Atty. Docket No.: 000479.00125 |
|                                     | ) |                                |
| For: MEASUREMENT AND SIGNATURE      | ) |                                |
| INTELLIGENCE ANALYSIS AND REDUCTION | ) |                                |
| TECHNIQUE                           | ) |                                |

**PRELIMINARY AMENDMENT**

U.S. Patent and Trademark Office  
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Customer Window  
Crystal Plaza Two, Lobby, Room 1B03  
Arlington, VA 22202

Sir:

Prior to examination and calculation of any claim fees, please amend the instant application as follows:

**Amendments to the Specification** begin on page 2 of this paper.

**Remarks/Arguments** begin on page 3 of this paper.